#### TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

# 2 S C 3 3 0 6

SWITCHING REGULATOR AND HIGH VOLTAGE SWITCHING APPLICATIONS.

HIGH SPEED DC-DC CONVERTER APPLICATIONS.

- Excellent Switching Times
  - :  $t_r = 1.0 \mu s$  (Max.),  $t_f = 1.0 \mu s$  (Max.) (IC=5A)
- High Collector Breakdown Voltage: VCEO=400V

### MAXIMUM RATINGS (Ta = 25°C)

CHARACT	SYMBOL	RATING	UNIT		
Collector-Base Voltage		$v_{\mathrm{CBO}}$	500	V	
Collector-Emitter Voltage		VCEO	400	V	
Emitter-Base Voltage		$V_{\mathrm{EBO}}$	7	V	
Collector Current	DC	$I_{\mathbf{C}}$	10	A	
	Pulse	ICP	15		
Base Current		$I_{\mathbf{B}}$	5	A	
Collector Power Dissipation (Tc=25°C)		PC	100	w	
Junction Temperature		$T_j$	150	°C	
Storage Temperature Range		$\mathrm{T_{stg}}$	-55~150	°C	

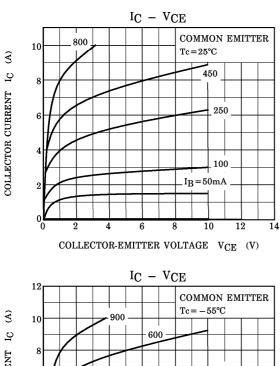
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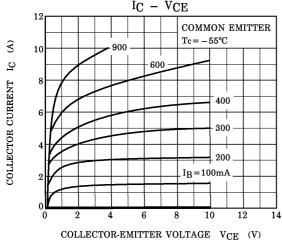
Weight: 4.7g

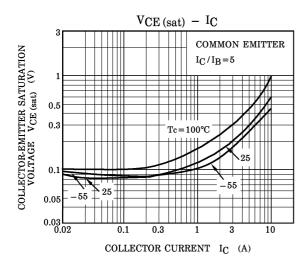
### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

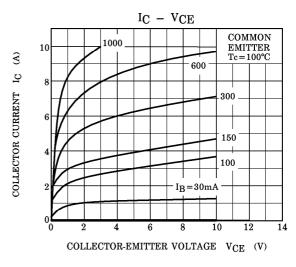
CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		ICBO	$V_{CB} = 400V, I_{E} = 0$	_	_	100	$\mu$ A
Emitter Cut-off Current		$I_{EBO}$	$V_{EB}=7V, I_{C}=0$		_	1	mA
Collector-Base Breakdown Voltage		V (BR) CBO	$I_{\rm C}=1$ mA, $I_{\rm E}=0$	500	_	_	V
Collector-Emitter Breakdown Voltage		V (BR) CEO	$I_{C}=10mA, I_{B}=0$	400	_	_	V
DC Current Gain		${ m h_{FE}}$	$V_C=5V$ , $I_C=5A$	10	_	_	
Collector-Emitter Saturation Voltage		V <sub>CE</sub> (sat)	$I_{C}=5A, I_{B}=0.5A$		_	1.5	V
Base-Emitter Saturation Voltage		V <sub>BE (sat)</sub>	$I_{C} = 5A, I_{B} = 0.5A$	_	_	2.0	V
Switching Time	Rise Time		$ \begin{array}{c c} 20\mu s & V_{CC} = 200V \\ I_{B1} & & & \\ I_{C1} & & & \\ \end{array} $	_	_	1.0	
	Storage Time	$t_{ ext{stg}}$	INPUT O W OUT-PUT	_	_	2.5	$\mu$ s
	Fall Time	tf	$I_{B2}$ $I_{B1} = -I_{B2} = 0.5A$ $DUTY CYCLE \le 1\%$		_	1.0	

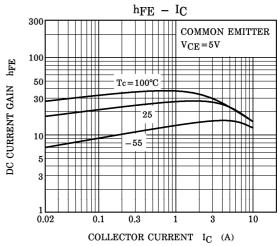
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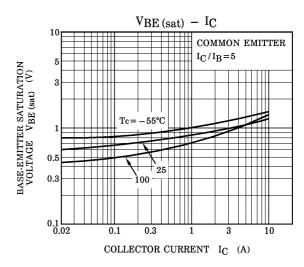




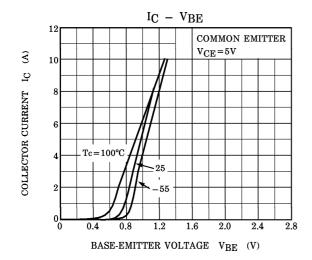


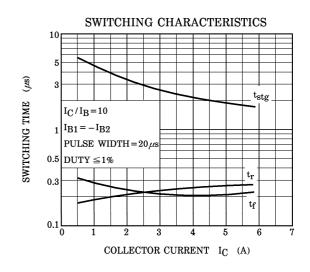


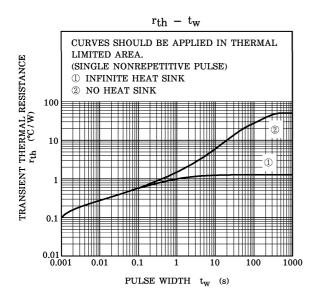


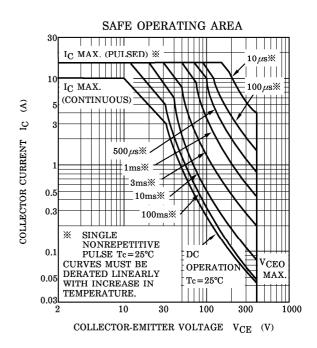


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